

Notice of References Cited	Application/Control No. 10/091,203		Applicant(s)/Patent Under Reexamination MAK ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,643,652 B2	11-2003	Helgeson et al.	707/10
	B	US-6,708,221 B1	03-2004	Mendez et al.	709/248
	C	US-6,341,291 B1	01-2002	Bentley et al.	707/203
	D	US-6,457,065 B1	09-2002	Rich et al.	719/328
	E	US-6,850,893 B2	02-2005	Lipkin et al.	705/8
	F	US-2005/0055420 A1	03-2005	Wylar, Eran Shmuel	709/217
	G	US-2003/0172113 A1	09-2003	Cameron et al.	709/204
	H	US-2003/0182450 A1	09-2003	Ong et al.	709/246
	I	US-5,928,329 A	07-1999	Clark et al.	709/227
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U	Markup Meets Middleware - Emmerich, Schwarz, al. (1999) □□www.cs.ucl.ac.uk/staff/W.Emmerich/publications/FTDCS99/m3.pdf			
	V	Efficient Filtering of XML Documents for Selective.. - Altinel, Franklin (2000) □□www.cs.umd.edu/users/altinel//pub/vldb00.pdf			
	W	WysiWyg Web Wrapper Factory (W4F) - Sahuguet, Azavant □□db.cis.upenn.edu/DL/WWW8/www8.ps.gz			
	X				

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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